

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination SHIH ET AL.	
		09/763,210	Examiner	Art Unit
		Dave T. Nguyen	1632	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,824,770	11-2004	Falck-Pedersen, Erik S.	424/93.2
	B	US-6,426,216	07-2002	Perricaudet et al.	435/320.1
	C	US-6,013,638	01-2000	Crystal et al.	514/44
	D	US-5,922,576	07-1999	He et al.	435/91.41
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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